THERMAL EMITTANCE MEASUREMENTS FROM NEGATIVE ELECTRON AFFINITY PHOTOCATHODES*

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Abstract

Recent computational optimizations have demonstrated that it should be possible to construct electron injectors based on photoemission cathodes in very high voltage DC electron guns in which the beam emittance is dominated by the thermal emittance from the cathode. Negative electron affinity (NEA) photocathodes are known to have a naturally low thermal emittance. However, the thermal emittance depends on the illuminating wavelength, the degree of negative affinity, and the band structure of the photocathode material. As part of the development of a high brightness, high average current photoemission electron gun for the injector of an ERL light source, we have measured the thermal emittance from negative affinity GaAs and GaAsP photocathodes. The measurements were made by obtaining the electron beam spot size downstream of a counter-wound solenoid lens as a function of the lens strength. Electron beam spot sizes were measured by two techniques: a $20 \,\mu m$ wire scanner, and a BeO screen. Excellent agreement in measured emittance has been obtained between these two methods and direct transverse phase space mapping using a $20\,\mu\mathrm{m}$ slit and the screen. Results are presented for both cathode types. The Cornell ERL injector performance is evaluated based on the results of these measurements.

INTRODUCTION

Cornell University is planning an ultra-bright x-ray light source based on the Energy Recovery Linac (ERL) concept. The key component of the ERL is a high average current, low emittance electron injector. To this end, Cornell has an ongoing program to develop a high brightness injector system based on high voltage DC gun technology. The DC gun has been built and is now operational [1]. To achieve the required low emittance, the transverse emittance degradation due to space charge has to be controlled. Simulation studies have shown that it should be possible to achieve a very high degree of emittance compensation in the Cornell ERL injector so that the final beam emittance is dominated by thermal emittance from the cathode [2]. An ideal photocathode, in addition to high quantum efficiency and robustness, would have very low thermal emittance and a short photoemission response time, the latter to take advantage of laser pulse shaping to mitigate nonlinear

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space charge [3, 4]. NEA photocathodes have been shown to have a naturally low thermal emittance. However, the thermal emittance depends on the illuminating wavelength, the degree of negative affinity, and the band structure of the photocathode material. Furthermore, GaAs photocathodes have been measured to have a relatively long photoemission tail when excited with photons near the bandgap[5]. Since absorption in GaAs is a strong function of photon energy, the use of shorter radiation wavelengths for excitation may be preferable due to the significantly faster photoemission response time. The optimum wavelength will depend on the detailed behavior of thermal emittance and photoemission response versus laser wavelength. An effort is underway to characterize the response time from various photocathode materials at wavelengths of interest.

Here we present a careful study of the thermal emittance from two types of negative electron affinity photocathodes, GaAs and GaAsP, versus the laser wavelength. We also present the optimal performance of the Cornell ERL injector operating with these photocathodes illuminated with a frequency doubled Yb-fiber laser system [6].

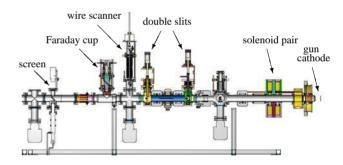


Figure 1: Beamline for thermal emittance studies. Beam direction is to the left.

EXPERIMENTAL SETUP

To commission the high-voltage DC gun and perform studies of the photocathodes and space charge dominated beam, a small beamline has been put together capable of transporting up to $100\,\mathrm{mA}$ DC beam current. The beamline section directly after the gun is used for thermal emittance studies, and is shown in Fig. 1. The identical back-to-back solenoids are located after the gun. The beamline is equipped with $20\,\mu\mathrm{m}$ double slits for emittance measurement of space charge dominated beam. The wire scanner, strung with $20\,\mu\mathrm{m}$ gold-plated tungsten wire, is positioned after the double slits, and is used to determine the beam

^{*}Supported by the NSF grant PHY-0131508 and NSF/NIH-NIGMS award DMR-0225180

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profile. The current signal from the wire is connected to a trans-impedance amplifier and sampled together with the encoder reading at a 500 Hz rate. We have also used a BeO screen to visualize the electron beam and perform beam profile measurements. The view-port is equipped with a 12-bit CCD camera interfaced to a computer. The experiment is controlled via EPICS and MATLAB®.

Four different lasers have been employed to cover the desired range of wavelengths: an argon-ion laser (460 nm), a solid-state green 5 mW (532 nm), a helium-neon laser (633 nm), and a Ti:sapphire laser (710–860 nm). Similar to [7], a laser-illuminated aperture is imaged 1:1 on the photocathode with an achromatic 1-m focal length lens. Additionally, each time a thermal emittance measurement was taken, the laser beam was diverted after the lens and imaged at the same distance from the lens as the photocathode using a SPIRICON®12-bit CCD camera. A typical laser spot image is shown in Fig. 2a.

GaAs wafers with Zn doping between 2×10^{18} and $2\times^{19}\,\mathrm{cm^{-3}}$ have been activated in the preparation chamber of a load-lock system connected to the gun. A yo-yo preparation with cesium and nitrogen trifluoride gave typical quantum efficiencies of 10% at 532 nm. GaAsP photocathodes have been activated in a similar fashion. GaAsP was epitaxially grown on GaAs substrates to a thickness of $2\,\mu\mathrm{m}$. The phosphorus concentration was 45% with a p-doping level of $2-4\times 10^{18}\,\mathrm{cm^{-3}}$. A $2\,\mu\mathrm{m}$ transition layer with graded phosphorus concentration separated the GaAs substrate and the GaAsP active layer.

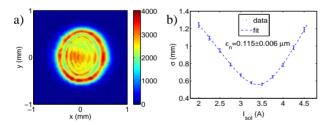


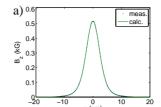
Figure 2: Sample data: a) measured laser profile; b) solenoid scan and fit (860 nm, GaAs).

MEASUREMENT METHOD

A standard procedure for the case of decoupled motion in absence of space charge and beam dispersion was used to fit the transverse beam sizes measured as a function of the solenoid lens strength [8]. The transfer matrices were calculated for the actual magnetic field profile of the two back-to-back identical solenoids (see Fig. 3).

Fig. 2b shows a typical solenoid scan and the fit. Most measurements were carried out at 250 kV gun voltage. A cross-check for emittance was carried out at 200 and 250 kV yielding the same normalized emittance within 1%.

All beam profile data taken with the wire scanner or the screen was fitted with a super-Gaussian $y=Ae^{-(x-x_0)^n/s^n}+B$ with free parameters A,B,n,s, and x_0 . The rms beam size is given by $s\sqrt{\Gamma(\frac{3}{n})/\Gamma(\frac{1}{n})}$. The 02 Synchrotron Light Sources and FELs



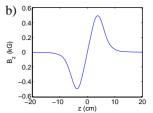


Figure 3: Solenoid field with 5 A excitation current: a) calculated and measured magnetic field of a single solenoid; b) magnetic field of two back-to-back identical solenoids.

largest error in determining the beam size is estimated to be 2%. The measurement uncertainty was propagated in a χ^2 -fit to the emittance [8]. Typical errors on the emittance add up to 5% for the wire scanner and the screen, and 7% for the slit and screen technique.

The transverse thermal energy of the cathode kT_{\perp} , which relates to the rms normalized emittance ϵ_n according to

$$\epsilon_n = \sigma_0 \sqrt{\frac{kT_\perp}{mc^2}},$$

 σ_0 being the laser spot size and mc^2 the electron rest energy, was obtained from the slope b of the χ^2 -fit of the data to $\epsilon_n = b\sigma_0$. The errors in both the laser spot σ_0 and the normalized emittance ϵ_n were taken into account. The typical uncertainty in determination of σ_0 was estimated to be 1% rms. The rms error to the slope b was determined from the $\Delta\chi^2=1$ condition.

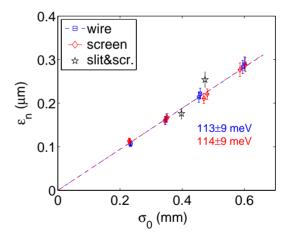


Figure 4: Comparison of various thermal emittance measurement techniques for GaAs at 532 nm.

RESULTS AND DISCUSSION

Comparison of the thermal emittance as determined by the three techniques for GaAs at 532 nm is shown in Fig. 4, demonstrating a very good agreement.

Fig. 5 and 6 show the result of the thermal emittance measurements at various wavelengths for GaAs and GaAsP photocathodes respectively. The thermal energy

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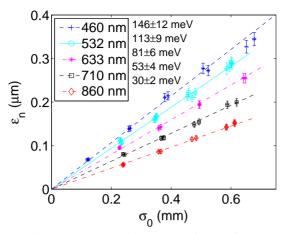


Figure 5: Measured thermal emittance for GaAs.

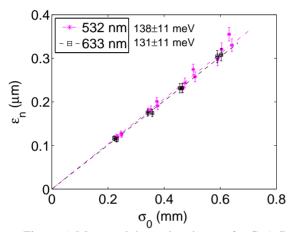


Figure 6: Measured thermal emittance for GaAsP.

at $532\,\mathrm{nm}$, near to the actual laser system wavelength of $520\,\mathrm{nm}$ [6], is found to be $113\pm9\,\mathrm{meV}$ for GaAs, and $138\pm11\,\mathrm{meV}$ for GaAsP. The bandgap of GaAsP, which undergoes a transition from direct to indirect gap for 45% phosphorus concentration, is closer matched to the laser wavelength than GaAs. Thus, the thermal energy of GaAsP was expected to be lower than that of pure GaAs at $532\,\mathrm{nm}$. Nevertheless, a larger kT_\perp was obtained from GaAsP photocathodes. At the moment, the large thermal energy from GaAsP photocathodes is not understood, but may reflect a large fraction of the emitting electrons arising from the X, rather than Γ minimum.

To investigate the implications of the measured thermal emittance of the photocathode, a simulation study similar to [2] has been carried out for the now fully designed Cornell ERL injector. The normalized transverse emittance at the location of emittance diagnostic instrumentation at the end of the full injector 9.5 m from the cathode is shown in Fig. 7 as a function of the final bunch length σ_z for a conservative value of $kT_\perp=150$ meV. Three different gun voltages were investigated: 350, 500, and 750 kV. The average kinetic energy of the beam at the end of the beamline is 11 MeV. The initial laser distribution was assumed to be a uniform cylinder consistent with the pulse shaping techniques applied to the laser system. The average laser pulse

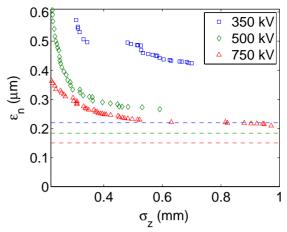


Figure 7: Performance of the DC gun injector with 77 pC bunches for a photocathode with $kT_{\perp}=150$ meV.

duration at the cathode is 13 ps rms. This pulse duration and temporal shaping is consistent with photoemission response of GaAs at 520 nm [9].

The dashed lines in Fig. 7 show the theoretical limit to the emittance from the full injector at three different gun voltages for bunched electron beams applicable to our injector. The limit to the lowest normalized emittance ϵ_n assuming a flat-top transverse laser shape is given by

$$\epsilon_n = \sqrt{\frac{Q \cdot kT_{\perp}}{4\pi\varepsilon_0 E_{\text{cath}} mc^2}},$$

here Q is the bunch charge, $E_{\rm cath}$ is the electric field at the cathode, ε_0 is the vacuum permittivity. It is seen from Fig. 7 that performance close to the theoretical limit can be achieved at both 500 and $750\,{\rm kV}$ gun voltage.

ACKNOWLEDGMENTS

We acknowledge John Dobbins and John Barley for technical support with the control system, and Alexander Temknykh for magnetic measurements of the solenoids.

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